

flow3xMNPC 1
1200 V/40 A
Features

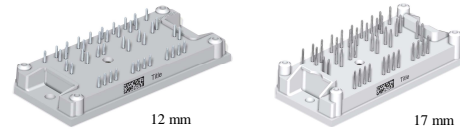
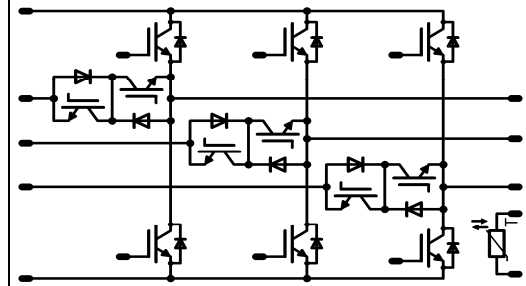
- 3 phase mixed voltage component topology
- neutral point clamped inverter
- reactive power capability
- low inductance layout

Target Applications

- solar inverter
- UPS

Types

- 10-FY12M3A040SH-M749F08
- 10-F112M3A040SH-M749F09

flow1 housing

Schematic


Maximum Ratings

 $T_j=25^\circ\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Half Bridge IGBT (T1,T4,T5,T8,T9,T12)				
Collector-emitter break down voltage	V_{CE}		1200	V
DC collector current	I_C	$T_j=T_{j,max}$ $T_n=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	31 41	A
Pulsed collector current	$I_{C,pulse}$	t_p limited by $T_{j,max}$	120	A
Power dissipation per IGBT	P_{tot}	$T_j=T_{j,max}$ $T_n=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	75 114	W
Turn off safe operating area	I_C	$T_j \leq 150^\circ\text{C}$ $V_{CE} \leq V_{CES}$	120	A
Short circuit ratings	t_{SC} V_{CC}	$T_j \leq 150^\circ\text{C}$ $V_{GE}=15\text{V}$	10 800	μs V
Gate-emitter peak voltage	V_{GE}		± 20	V
Maximum Junction Temperature	$T_{j,max}$		175	$^\circ\text{C}$
Neutral P. FWD (D2,D3,D6,D7,D10,D11)				
Peak Repetitive Reverse Voltage	V_{RRM}		600	V
DC forward current	I_F	$T_j=T_{j,max}$ $T_n=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	18 26	A
Surge forward current	I_{FSM}	t_p limited by $T_{j,max}$	300	A
Power dissipation per Diode	P_{tot}	$T_j=T_{j,max}$ $T_n=80^\circ\text{C}$ $T_c=80^\circ\text{C}$	30 45	W
Maximum Junction Temperature	$T_{j,max}$		150	$^\circ\text{C}$

Maximum Ratings

$T_j=25^{\circ}\text{C}$, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Neutral P. IGBT (T2,T3,T6,T7,T10,T11)				
Collector-emitter break down voltage	V_{CE}		600	V
DC collector current	I_C	$T_j=T_{jmax}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	23 29	A
Pulsed collector current	I_{Cpuls}	t_p limited by T_{jmax}	90	A
Power dissipation per IGBT	P_{tot}	$T_j=T_{jmax}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	37 56	W
Gate-emitter peak voltage	V_{GE}		± 20	V
Short circuit ratings	t_{SC}	$T_j \leq 150^{\circ}\text{C}$	6	μs
	V_{CC}	$V_{GE}=15\text{V}$	360	V
Turn off safe operating area (RBSOA)	I_{cmax}	$V_{CEmax} = 600\text{V}$ $T_{vjmax} = 150^{\circ}\text{C}$	90	A
Maximum Junction Temperature	T_{jmax}		175	$^{\circ}\text{C}$

Half Bridge FWD (D1,D4,D5,D8,D9,D12)

Peak Repetitive Reverse Voltage	V_{RRM}		1200	V
DC forward current	I_F	$T_j=T_{jmax}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	12 14	A
Surge forward current	I_{FSM}	10 ms, sin 180° $T_j = 150^{\circ}\text{C}$	65	A
Power dissipation per Diode	P_{tot}	$T_j=T_{jmax}$ $T_h=80^{\circ}\text{C}$ $T_c=80^{\circ}\text{C}$	28	W
			43	
Maximum Junction Temperature	T_{jmax}		175	$^{\circ}\text{C}$

Thermal Properties

Storage temperature	T_{stg}		-40...+125	$^{\circ}\text{C}$
Operation temperature under switching condition	T_{op}		-40...+($T_{jmax} - 25$)	$^{\circ}\text{C}$

Insulation Properties

Insulation voltage	V_{is}	$t=2\text{s}$ DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance			min 12,7	mm

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		V_{GE} [V] or V_{GS} [V]	V_i [V] or V_{CE} [V] or V_{DS} [V]	I_c [A] or I_f [A] or I_b [A]	T_j	Min	Typ	Max		
Half Bridge IGBT (T1,T4,T5,T8,T9,T12)										
Gate emitter threshold voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}$			0,0015	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	5,2	5,8	6,4	V
Collector-emitter saturation voltage	$V_{CE(sat)}$		15		40	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	1,7	1,96 2,29	2,4	V
Collector-emitter cut-off current incl. Diode	I_{CES}		0	1200		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			0,005	mA
Gate-emitter leakage current	I_{GES}		20	0		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			120	nA
Integrated Gate resistor	R_{gint}							none		Ω
Turn-on delay time	$t_{d(on)}$	$R_{goff}=8\ \Omega$ $R_{gon}=8\ \Omega$	± 15	350	28	$T_j=25^\circ\text{C}$		70		ns
Rise time	t_r					$T_j=125^\circ\text{C}$		72		
Turn-off delay time	$t_{d(off)}$					$T_j=25^\circ\text{C}$		13		
Fall time	t_f					$T_j=125^\circ\text{C}$		15		
Turn-on energy loss per pulse	E_{on}					$T_j=25^\circ\text{C}$		166		
Turn-off energy loss per pulse	E_{off}					$T_j=125^\circ\text{C}$		217		
Input capacitance	C_{ies}							2300		pF
Output capacitance	C_{oss}	$f=1\text{MHz}$	0	25		$T_j=25^\circ\text{C}$		150		
Reverse transfer capacitance	C_{riss}							135		
Gate charge	Q_{gate}		± 15	960	40	$T_j=25^\circ\text{C}$		185		nC
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu\text{m}$ $\lambda = 1\ \text{W/mK}$						1,27		K/W
Neutral P. FWD (D2,D3,D6,D7,D10,D11)										
Diode forward voltage	V_F				30	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		2,28 1,74	2,5	V
Reverse leakage current	I_r			600		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			100 500	μA
Peak reverse recovery current	I_{RRM}	$R_{goff}=8\ \Omega$	± 15	350	28	$T_j=25^\circ\text{C}$		32		A
Reverse recovery time	t_{rr}					$T_j=125^\circ\text{C}$		41		
Reverse recovered charge	Q_{rr}					$T_j=25^\circ\text{C}$		18		
Peak rate of fall of recovery current	$di(rec)_{max}/dt$					$T_j=125^\circ\text{C}$		40		
Reverse recovered energy	E_{rec}					$T_j=25^\circ\text{C}$		0,32		
Thermal resistance chip to heatsink per chip	R_{thJH}					Thermal grease thickness $\leq 50\mu\text{m}$ $\lambda = 1\ \text{W/mK}$				
								0,03 0,12		mWs
								2,34		K/W

Characteristic Values

Parameter	Symbol	Conditions					Value			Unit
		V_{GE} [V] or V_{GS} [V]	V_i [V] or V_{CE} [V] or V_{DS} [V]	I_c [A] or I_f [A] or I_b [A]	T_j	Min	Typ	Max		
Neutral P. IGBT (T2,T3,T6,T7,T10,T11)										
Gate emitter threshold voltage	$V_{GE(th)}$	$V_{CE}=V_{GE}$				$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	5	5,80	6,5	V
Collector-emitter saturation voltage	$V_{CE(sat)}$				0,002	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$	1,1	1,52 1,70	1,9	V
Collector-emitter cut-off incl diode	I_{CES}		15		30	$T_j=25^\circ\text{C}$ $T_i=125^\circ\text{C}$			0,0016	mA
Gate-emitter leakage current	I_{GES}		0	600					300	nA
Integrated Gate resistor	R_{gint}							none		Ω
Turn-on delay time	$t_{d(on)}$					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		105 105		ns
Rise time	t_r					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		11 16		
Turn-off delay time	$t_{d(off)}$	$R_{goff}=16 \Omega$ $R_{gon}=16 \Omega$	± 15	350	28	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		164 187		
Fall time	t_f					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		74 91		
Turn-on energy loss per pulse	E_{on}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,49 0,66		mWs
Turn-off energy loss per pulse	E_{off}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,76 0,98		
Input capacitance	C_{iss}							1630		pF
Output capacitance	C_{oss}	$f=1\text{MHz}$	0	25		$T_j=25^\circ\text{C}$		108		
Reverse transfer capacitance	C_{riss}							50		
Gate charge	Q_{gate}		15	480	30	$T_j=25^\circ\text{C}$		167		nC
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu\text{m}$ $\lambda = 1 \text{ W/mK}$						2,56		K/W
Half Bridge FWD (D1,D4,D5,D8,D9,D12)										
Diode forward voltage	V_F				15	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		2,28 2,39	2,71	V
Reverse leakage current	I_r			1200		$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$			60	μA
Peak reverse recovery current	I_{RRM}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		41 44		A
Reverse recovery time	t_{rr}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		44 110		ns
Reverse recovered charge	Q_{rr}	$R_{goff}=16 \Omega$	± 15	350	28	$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		1,47 2,73		μC
Peak rate of fall of recovery current	$di(rec)_{max}/dt$					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		5094 3534		A/ μs
Reverse recovery energy	E_{rec}					$T_j=25^\circ\text{C}$ $T_j=125^\circ\text{C}$		0,35 0,71		mWs
Thermal resistance chip to heatsink per chip	R_{thJH}	Thermal grease thickness $\leq 50\mu\text{m}$ $\lambda = 1 \text{ W/mK}$						3,36		K/W
Thermistor										
Rated resistance	R					$T_j=25^\circ\text{C}$		21511		Ω
Deviation of R100	$\Delta R/R$	$R_{100}=1486 \Omega$				$T_c=100^\circ\text{C}$	-4,5		+4,5	%
Power dissipation	P					$T_j=25^\circ\text{C}$		210		mW
Power dissipation constant						$T_j=25^\circ\text{C}$		3,5		mW/K
B-value	$B_{(25/50)}$					$T_j=25^\circ\text{C}$		3884		K
B-value	$B_{(25/100)}$					$T_j=25^\circ\text{C}$		3964		K
Vincotech NTC Reference						$T_j=25^\circ\text{C}$			F	

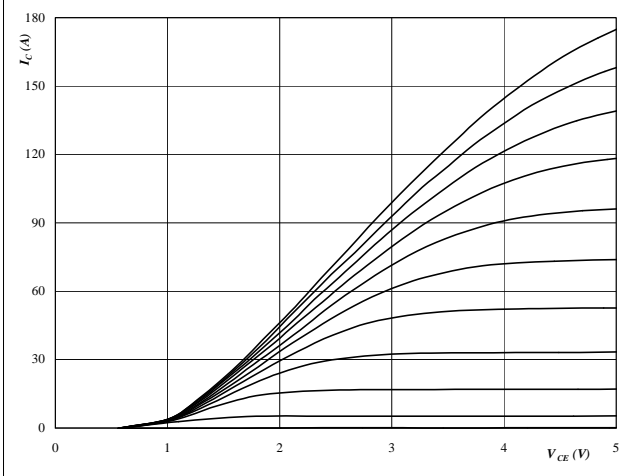
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Half Bridge IGBT and Neutral Point FWD

Figure 1 IGBT

Typical output characteristics

$I_C = f(V_{CE})$

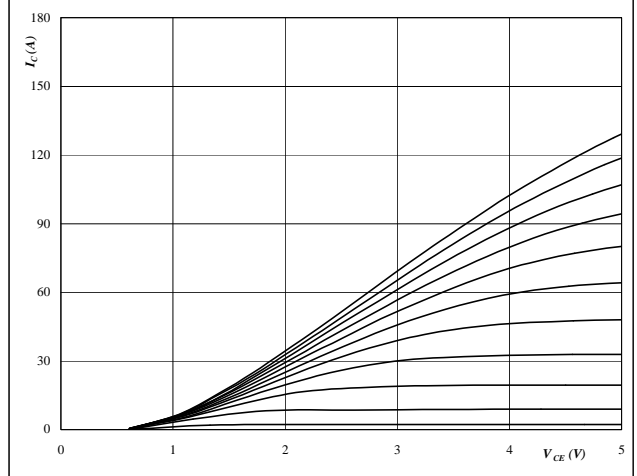


At
 $t_p = 250 \mu s$
 $T_j = 25 \text{ }^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 2 IGBT

Typical output characteristics

$I_C = f(V_{CE})$

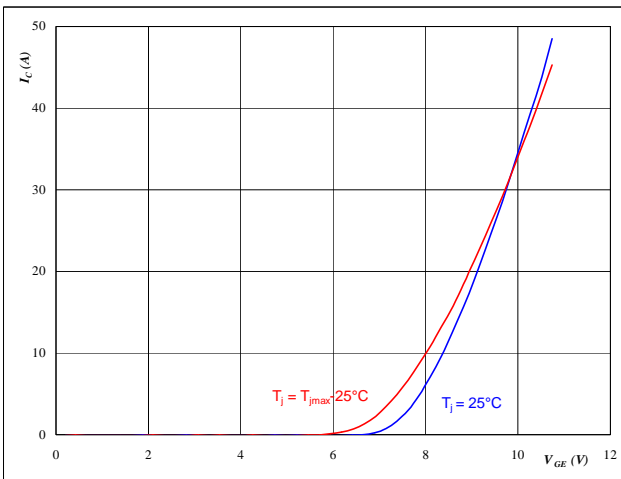


At
 $t_p = 250 \mu s$
 $T_j = 125 \text{ }^\circ C$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 3 IGBT

Typical transfer characteristics

$I_C = f(V_{GE})$

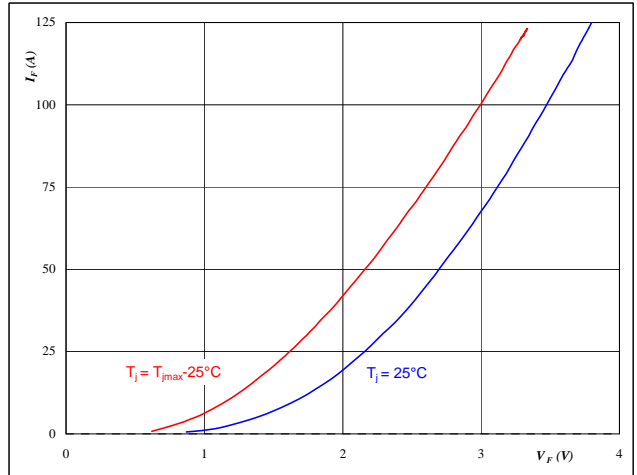


At
 $t_p = 250 \mu s$
 $V_{CE} = 10 V$

Figure 4 FWD

Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$



At
 $t_p = 250 \mu s$

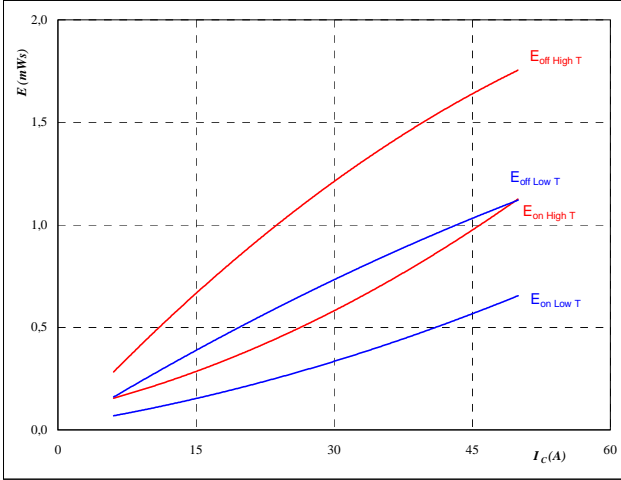
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Half Bridge IGBT and Neutral Point FWD

Figure 5 IGBT

Typical switching energy losses
as a function of collector current

$$E = f(I_C)$$



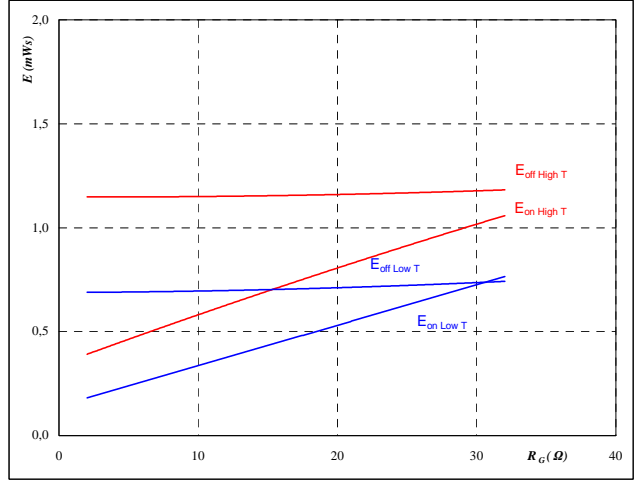
With an inductive load at

$T_J =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	8	Ω
$R_{goff} =$	8	Ω

Figure 6 IGBT

Typical switching energy losses
as a function of gate resistor

$$E = f(R_G)$$



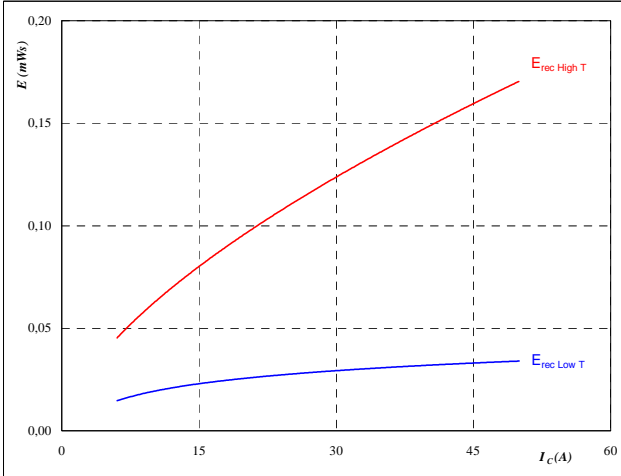
With an inductive load at

$T_J =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$I_C =$	28	A

Figure 7 FWD

Typical reverse recovery energy loss
as a function of collector current

$$E_{rec} = f(I_C)$$



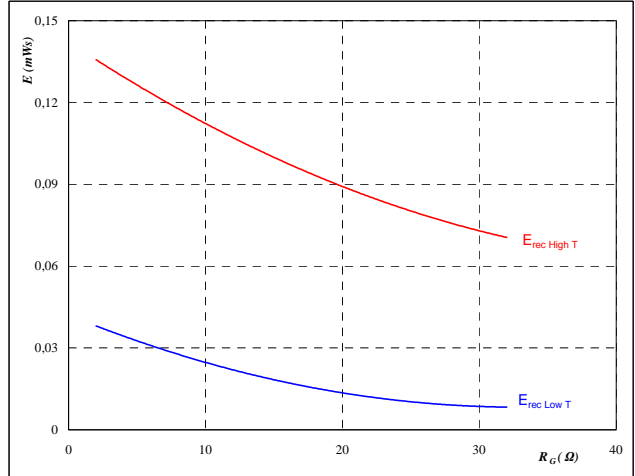
With an inductive load at

$T_J =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	8	Ω

Figure 8 FWD

Typical reverse recovery energy loss
as a function of gate resistor

$$E_{rec} = f(R_G)$$



With an inductive load at

$T_J =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$I_C =$	28	A

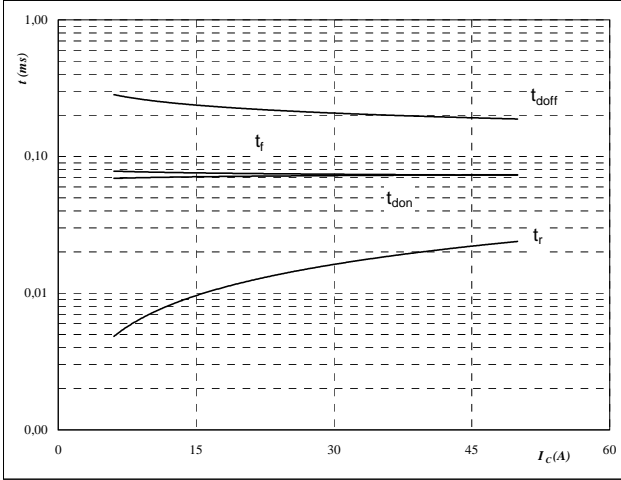
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Half Bridge IGBT and Neutral Point FWD

Figure 9 IGBT

Typical switching times as a function of collector current

$$t = f(I_C)$$



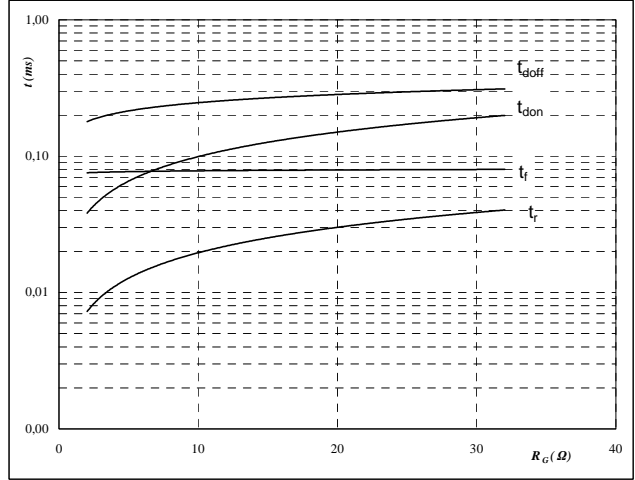
With an inductive load at

$T_J =$	125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	8	Ω
$R_{goff} =$	8	Ω

Figure 10 IGBT

Typical switching times as a function of gate resistor

$$t = f(R_G)$$



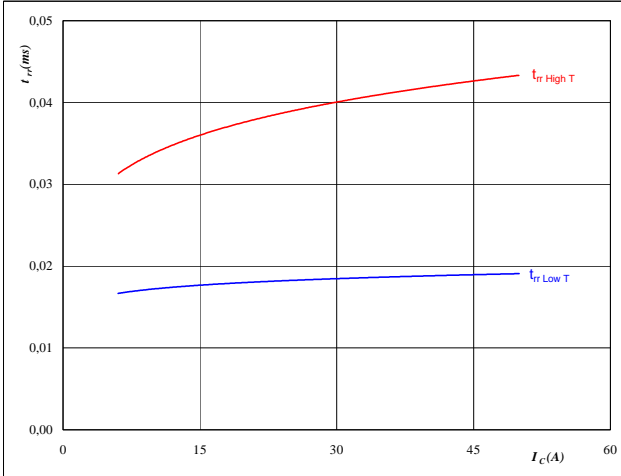
With an inductive load at

$T_J =$	125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$I_C =$	28	A

Figure 11 FWD

Typical reverse recovery time as a function of collector current

$$t_{rr} = f(I_C)$$



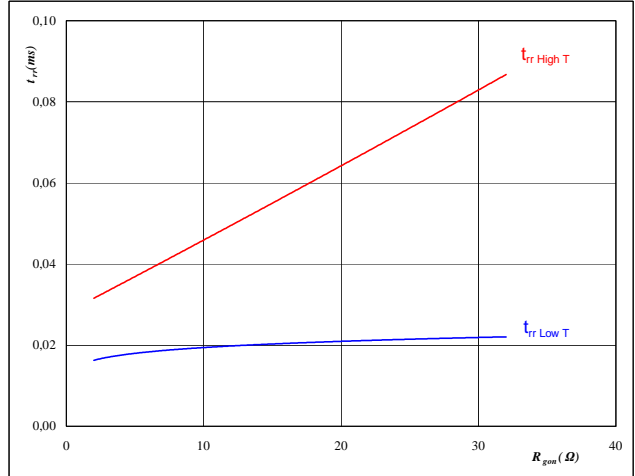
At

$T_J =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	8	Ω

Figure 12 FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

$$t_{rr} = f(R_{gon})$$



At

$T_J =$	25/125	°C
$V_R =$	350	V
$I_F =$	28	A
$V_{GE} =$	±15	V

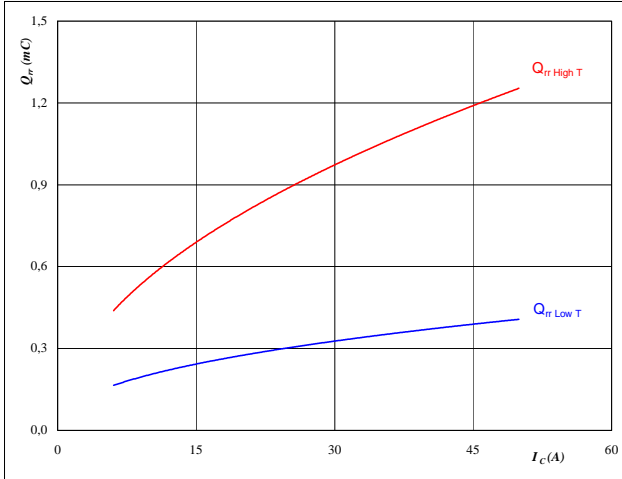
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Half Bridge IGBT and Neutral Point FWD

Figure 13 FWD

Typical reverse recovery charge as a function of collector current

$$Q_{rr} = f(I_C)$$

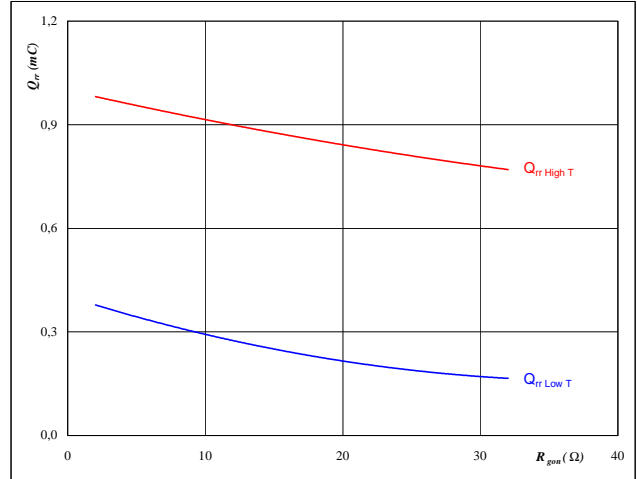


At
 $T_j = 25/125$ °C
 $V_{CE} = 350$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 8$ Ω

Figure 14 FWD

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$$Q_{rr} = f(R_{gon})$$

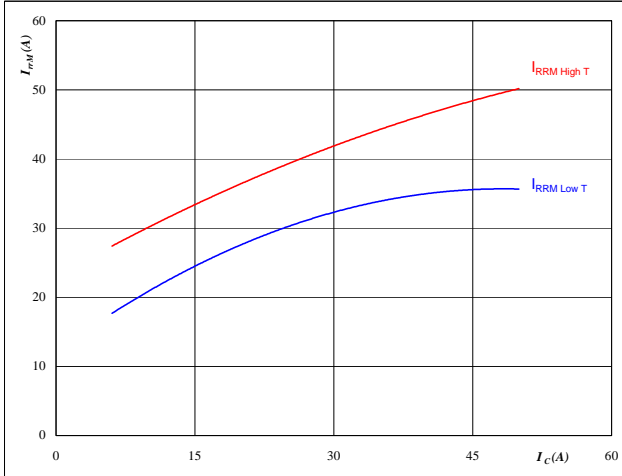


At
 $T_j = 25/125$ °C
 $V_R = 350$ V
 $I_F = 28$ A
 $V_{GE} = \pm 15$ V

Figure 15 FWD

Typical reverse recovery current as a function of collector current

$$I_{RRM} = f(I_C)$$

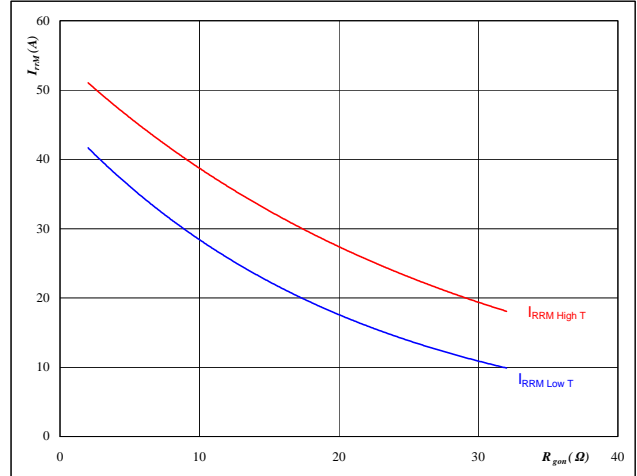


At
 $T_j = 25/125$ °C
 $V_{CE} = 350$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 8$ Ω

Figure 16 FWD

Typical reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RRM} = f(R_{gon})$$



At
 $T_j = 25/125$ °C
 $V_R = 350$ V
 $I_F = 28$ A
 $V_{GE} = \pm 15$ V

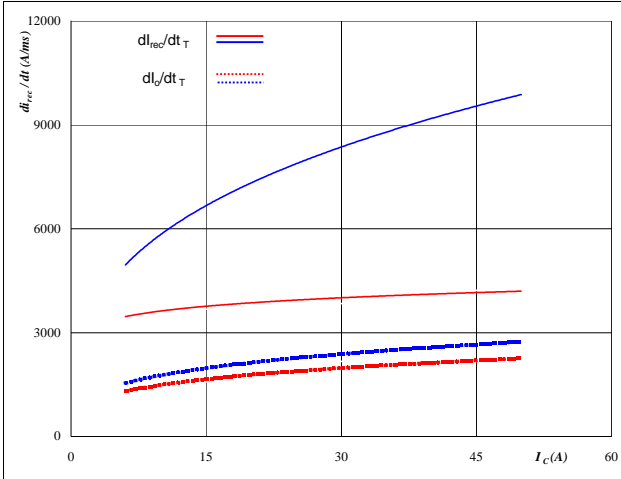
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Half Bridge IGBT and Neutral Point FWD

Figure 17 FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current

$$di_f/dt, di_{rec}/dt = f(I_c)$$

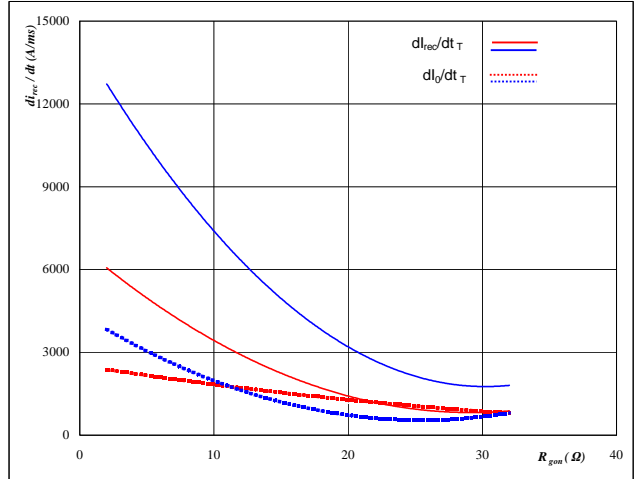


At
 $T_j = 25/125$ °C
 $V_{CE} = 350$ V
 $V_{GE} = \pm 15$ V
 $R_{gon} = 8$ Ω

Figure 18 FWD

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$$di_f/dt, di_{rec}/dt = f(R_{gon})$$

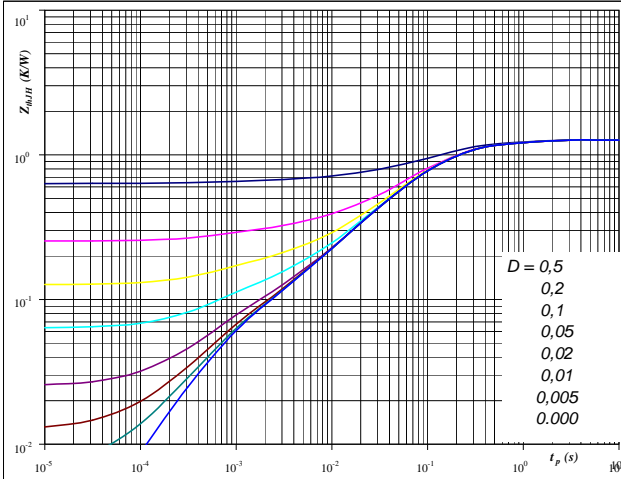


At
 $T_j = 25/125$ °C
 $V_R = 350$ V
 $I_F = 28$ A
 $V_{GE} = \pm 15$ V

Figure 19 IGBT

IGBT transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At
 $D = t_p / T$
 $R_{thJH} = 1,27$ K/W

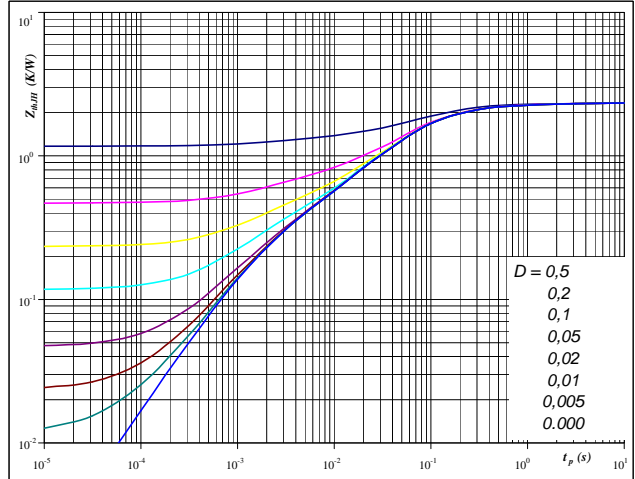
IGBT thermal model values

R (C/W)	Tau (s)
0,18	8,2E-01
0,64	1,3E-01
0,30	4,8E-02
0,10	9,3E-03
0,06	8,0E-04

Figure 20 FWD

FWD transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At
 $D = t_p / T$
 $R_{thJH} = 2,34$ K/W

FWD thermal model values

R (C/W)	Tau (s)
0,11	2,4E+00
0,36	3,0E-01
1,41	6,5E-02
0,28	1,1E-02
0,19	1,6E-03

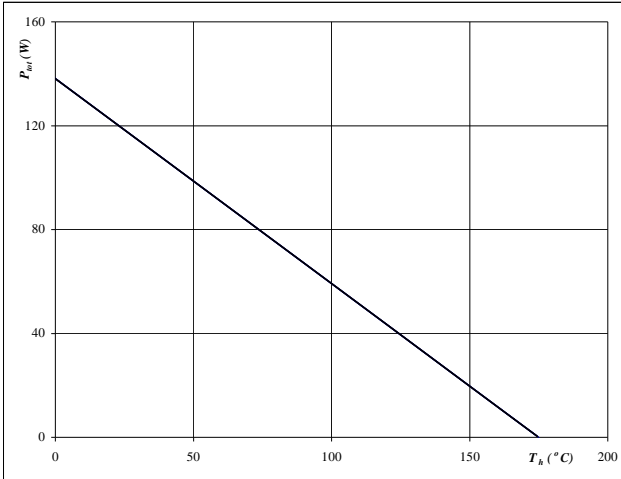
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Half Bridge IGBT and Neutral Point FWD

Figure 21 IGBT

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

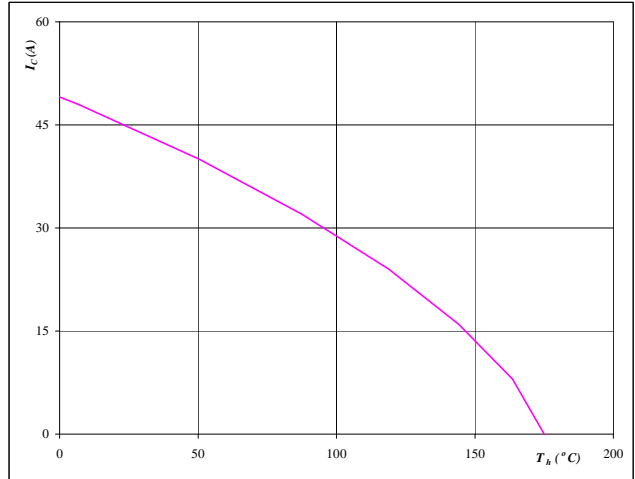


At
 $T_j = 175$ °C

Figure 22 IGBT

Collector current as a function of heatsink temperature

$$I_C = f(T_h)$$

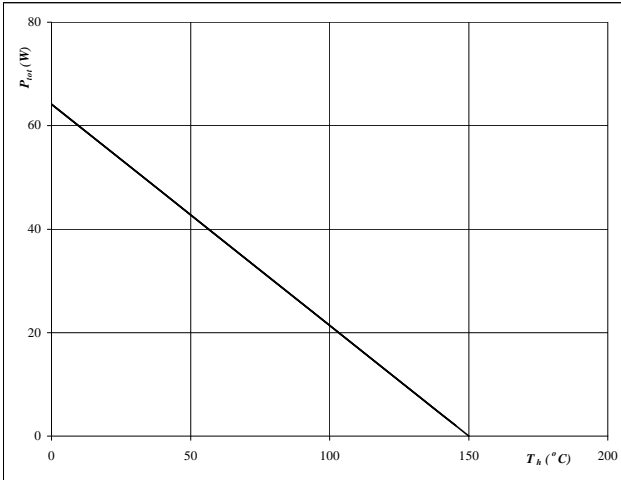


At
 $T_j = 175$ °C
 $V_{GE} = 15$ V

Figure 23 FWD

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

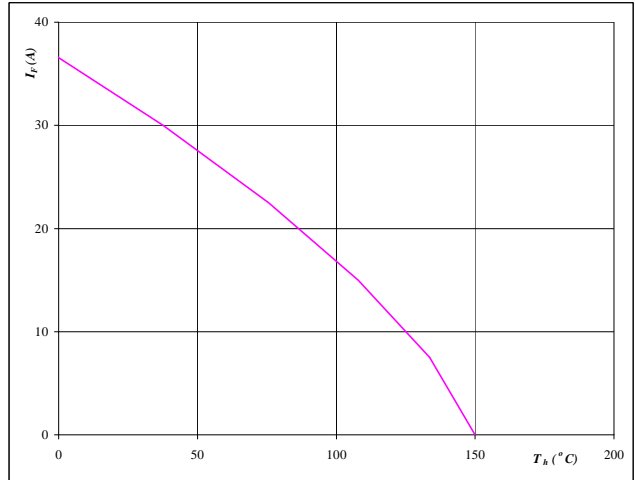


At
 $T_j = 150$ °C

Figure 24 FWD

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$



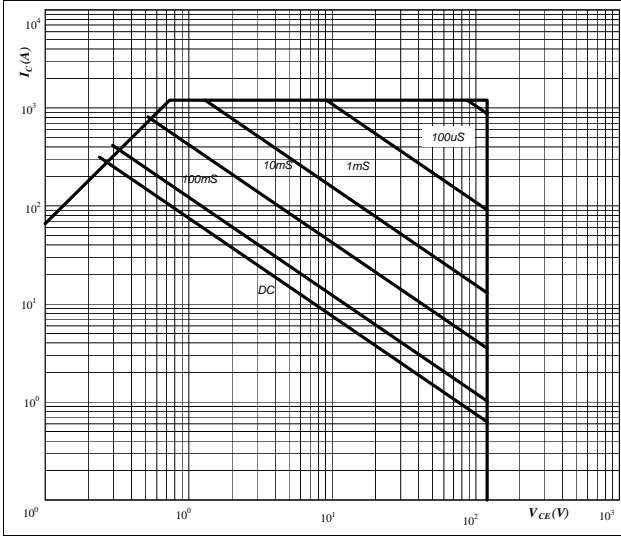
At
 $T_j = 150$ °C

Buck

Half Bridge IGBT and Neutral Point FWD

Figure 25 IGBT

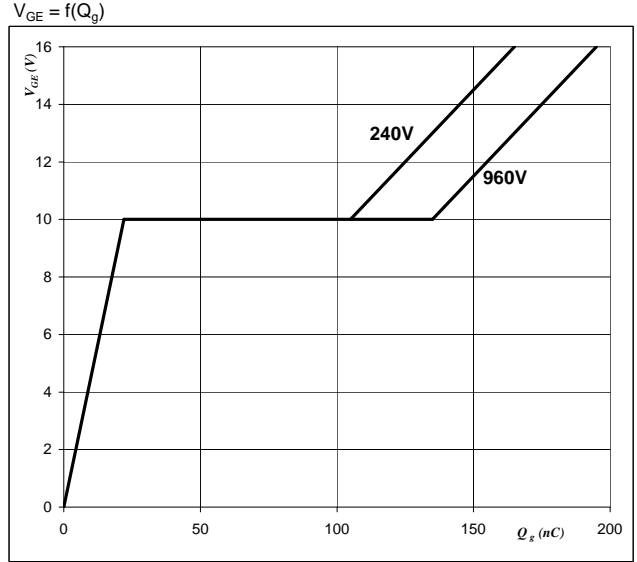
Safe operating area as a function of collector-emitter voltage
 $I_C = f(V_{CE})$



At
 D = single pulse
 Th = 80 °C
 V_{GE} = ±15 V
 T_j = T_{jmax} °C

Figure 26 IGBT

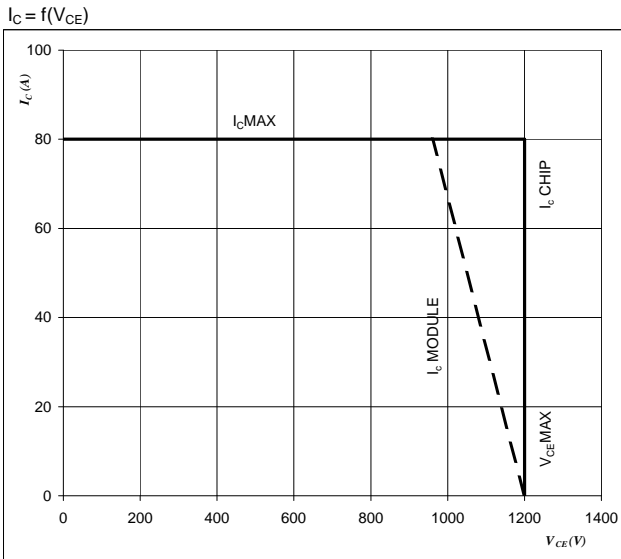
Gate voltage vs Gate charge
 $V_{GE} = f(Q_g)$



At
 I_C = 40 A

Figure 27 IGBT

Reverse bias safe operating area



At
 T_j = T_{jmax}-25 °C
 DC link_{minus}=DC link_{plus}
 Switching mode : 3 level switching

Boost

Neutral Point IGBT and Half Bridge FWD

Figure 1 IGBT

Typical output characteristics

$I_C = f(V_{CE})$

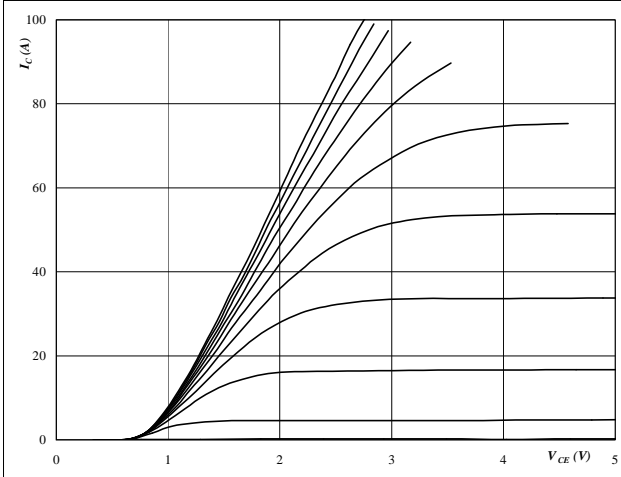

At
 $t_p = 250 \mu\text{s}$
 $T_j = 25 \text{ }^\circ\text{C}$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 2 IGBT

Typical output characteristics

$I_C = f(V_{CE})$

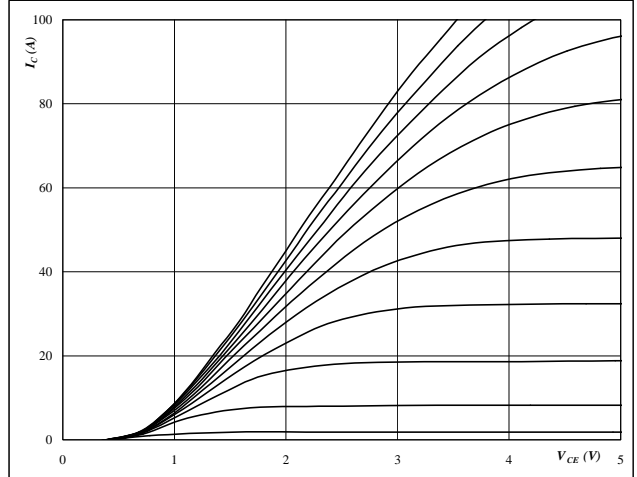
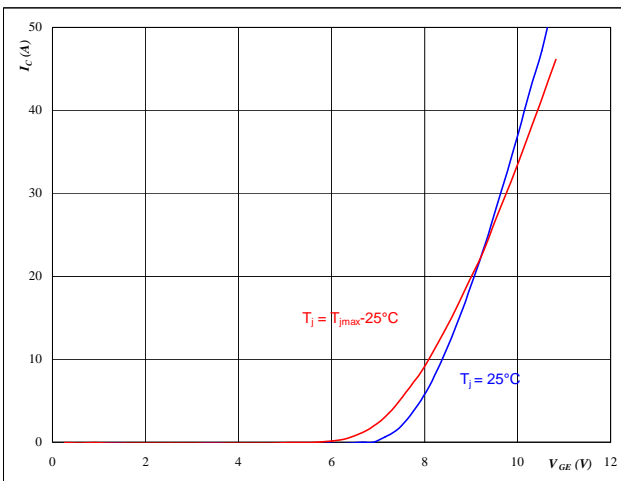

At
 $t_p = 250 \mu\text{s}$
 $T_j = 125 \text{ }^\circ\text{C}$
 V_{GE} from 7 V to 17 V in steps of 1 V

Figure 3 IGBT

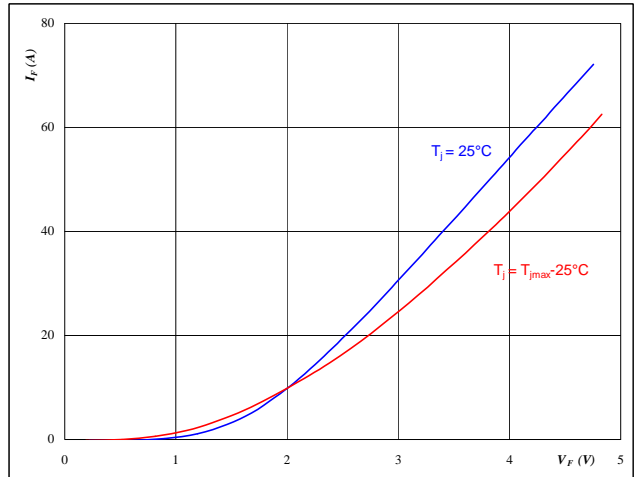
Typical transfer characteristics

$I_C = f(V_{GE})$


At
 $t_p = 250 \mu\text{s}$
 $V_{CE} = 10 \text{ V}$
Figure 4 FWD

Typical diode forward current as a function of forward voltage

$I_F = f(V_F)$


At
 $t_p = 250 \mu\text{s}$

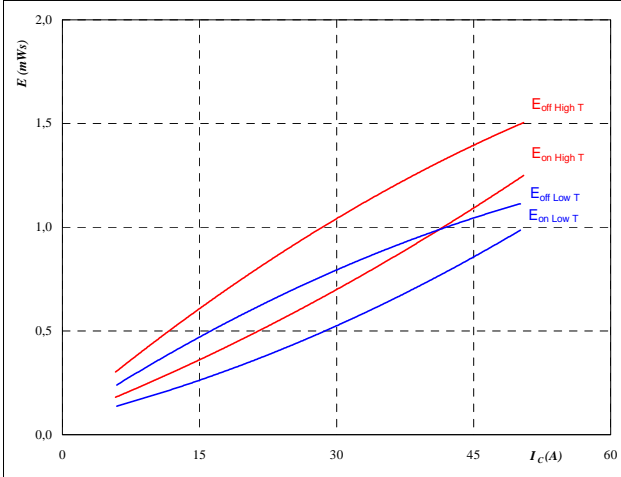
Boost

Neutral Point IGBT and Half Bridge FWD

Figure 5 IGBT

Typical switching energy losses
as a function of collector current

$$E = f(I_C)$$



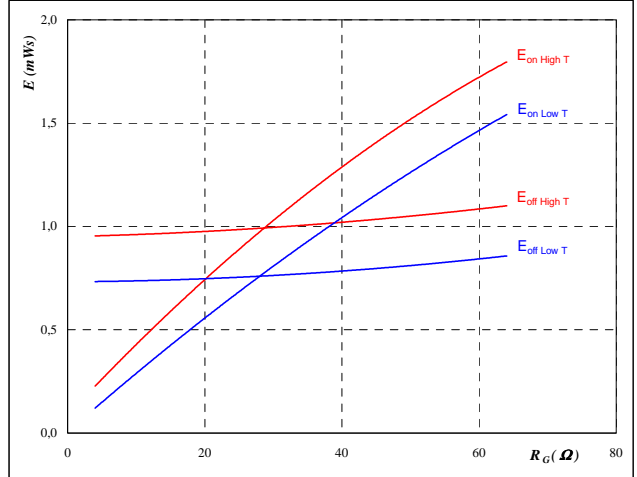
With an inductive load at

$T_J =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	16	Ω
$R_{goff} =$	16	Ω

Figure 6 IGBT

Typical switching energy losses
as a function of gate resistor

$$E = f(R_G)$$



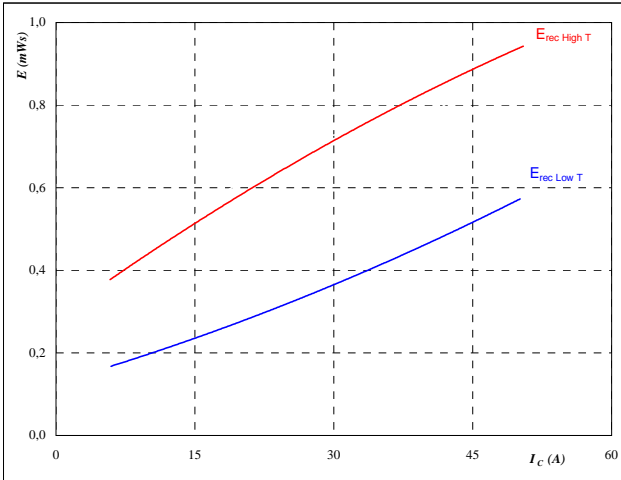
With an inductive load at

$T_J =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$I_C =$	28	A

Figure 7 FWD

Typical reverse recovery energy loss
as a function of collector current

$$E_{rec} = f(I_C)$$



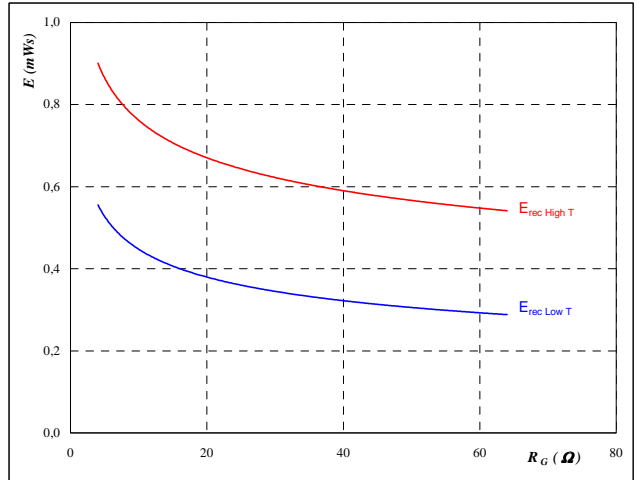
With an inductive load at

$T_J =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	16	Ω

Figure 8 FWD

Typical reverse recovery energy loss
as a function of gate resistor

$$E_{rec} = f(R_G)$$



With an inductive load at

$T_J =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$I_C =$	28	A

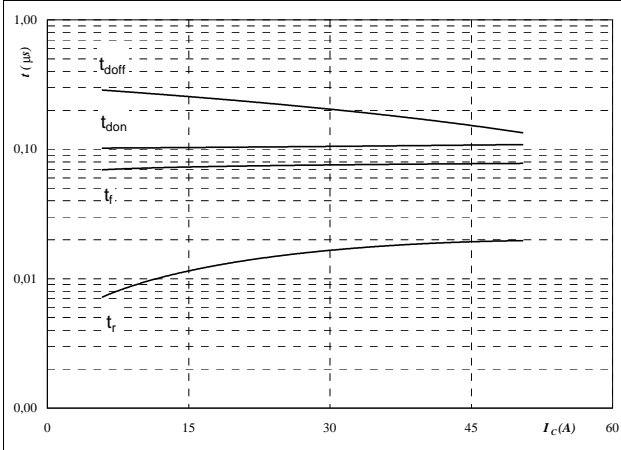
Boost

Neutral Point IGBT and Half Bridge FWD

Figure 9 IGBT

Typical switching times as a function of collector current

$$t = f(I_C)$$



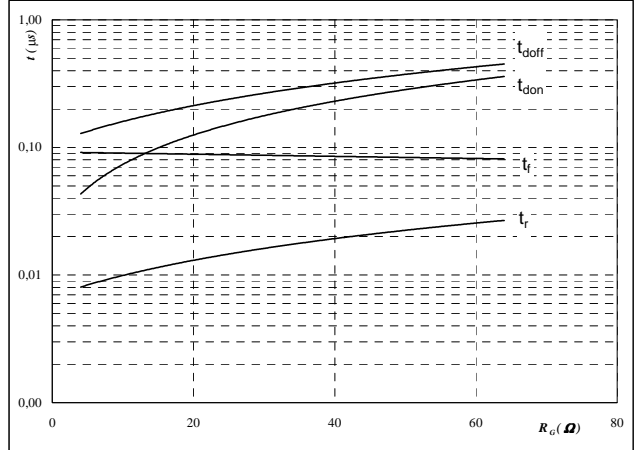
With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	16	Ω
$R_{goff} =$	16	Ω

Figure 10 IGBT

Typical switching times as a function of gate resistor

$$t = f(R_G)$$



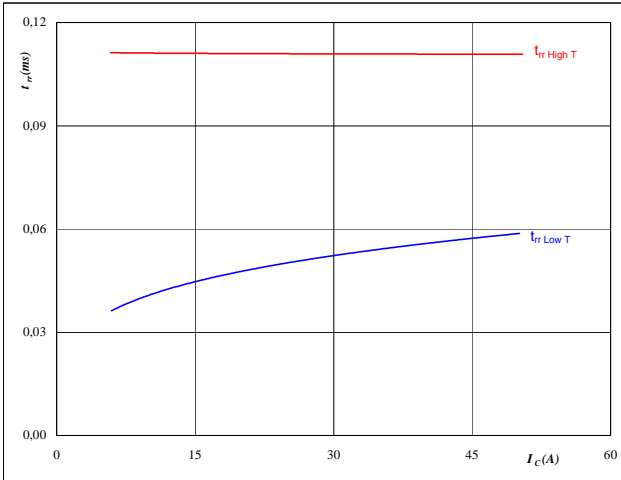
With an inductive load at

$T_j =$	125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$I_C =$	28	A

Figure 11 FWD

Typical reverse recovery time as a function of collector current

$$t_{rr} = f(I_C)$$



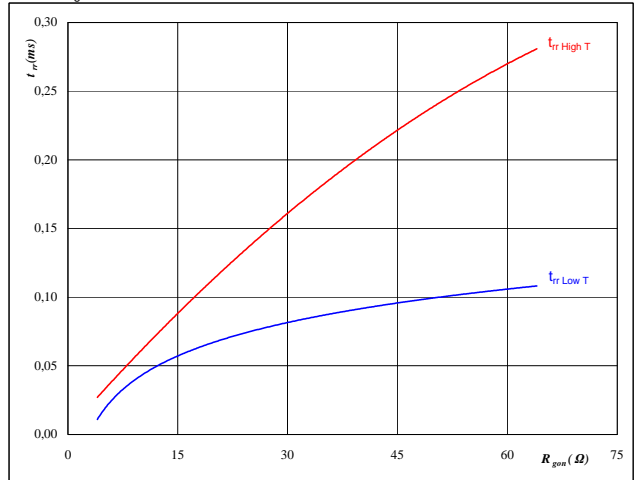
At

$T_j =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	16	Ω

Figure 12 FWD

Typical reverse recovery time as a function of IGBT turn on gate resistor

$$t_{rr} = f(R_{gon})$$



At

$T_j =$	25/125	°C
$V_R =$	350	V
$I_F =$	28	A
$V_{GE} =$	±15	V

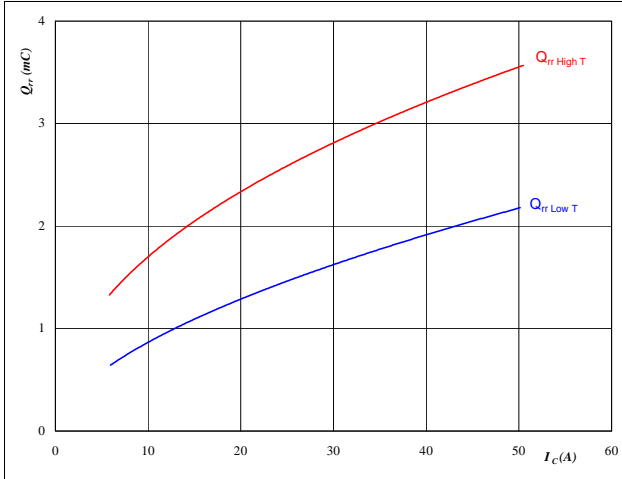
Boost

Neutral Point IGBT and Half Bridge FWD

Figure 13 FWD

Typical reverse recovery charge as a function of collector current

$$Q_{rr} = f(I_C)$$



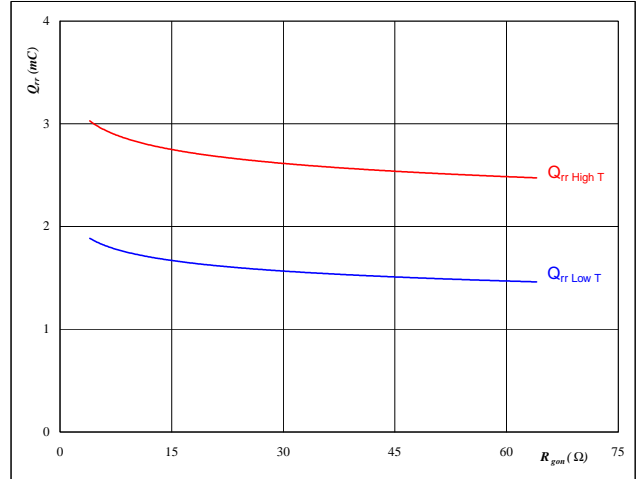
At

$T_j =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	16	Ω

Figure 14 FWD

Typical reverse recovery charge as a function of IGBT turn on gate resistor

$$Q_{rr} = f(R_{gon})$$



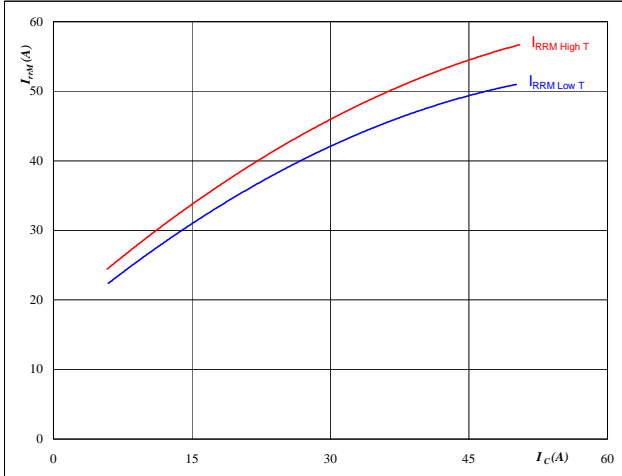
At

$T_j =$	25/125	°C
$V_R =$	350	V
$I_F =$	28	A
$V_{GE} =$	±15	V

Figure 15 FWD

Typical reverse recovery current as a function of collector current

$$I_{RRM} = f(I_C)$$



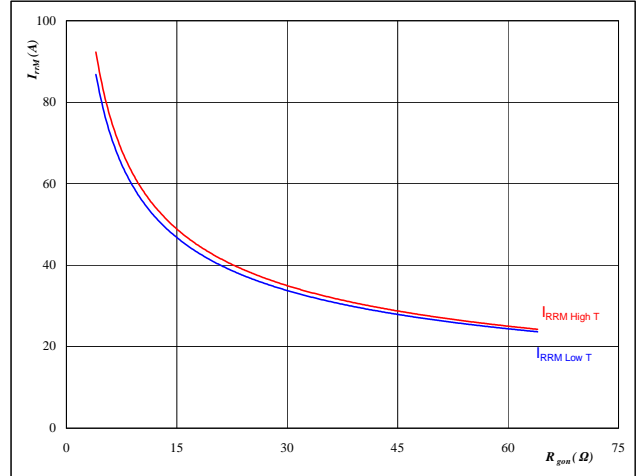
At

$T_j =$	25/125	°C
$V_{CE} =$	350	V
$V_{GE} =$	±15	V
$R_{gon} =$	16	Ω

Figure 16 FWD

Typical reverse recovery current as a function of IGBT turn on gate resistor

$$I_{RRM} = f(R_{gon})$$



At

$T_j =$	25/125	°C
$V_R =$	350	V
$I_F =$	28	A
$V_{GE} =$	±15	V

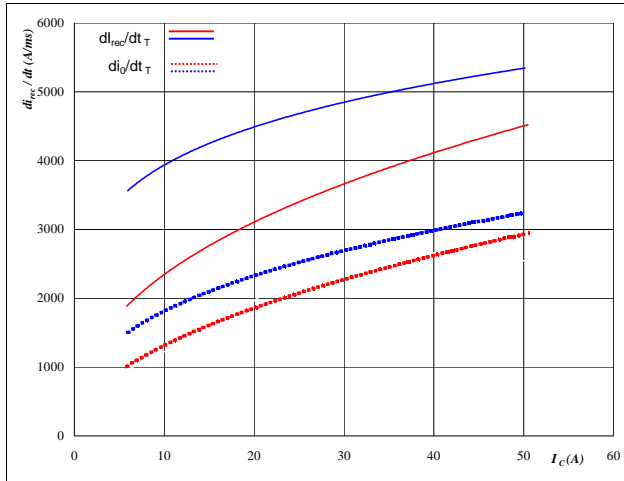
Boost

Neutral Point IGBT and Half Bridge FWD

Figure 17 FWD

Typical rate of fall of forward and reverse recovery current as a function of collector current

$$di_o/dt, di_{rec}/dt = f(I_c)$$

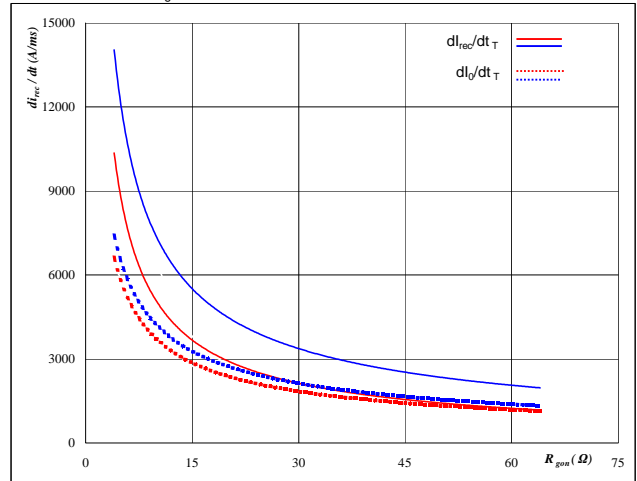


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_{CE} = 350 \text{ V}$
 $V_{GE} = \pm 15 \text{ V}$
 $R_{gon} = 16 \text{ } \Omega$

Figure 18 FWD

Typical rate of fall of forward and reverse recovery current as a function of IGBT turn on gate resistor

$$di_o/dt, di_{rec}/dt = f(R_{gon})$$

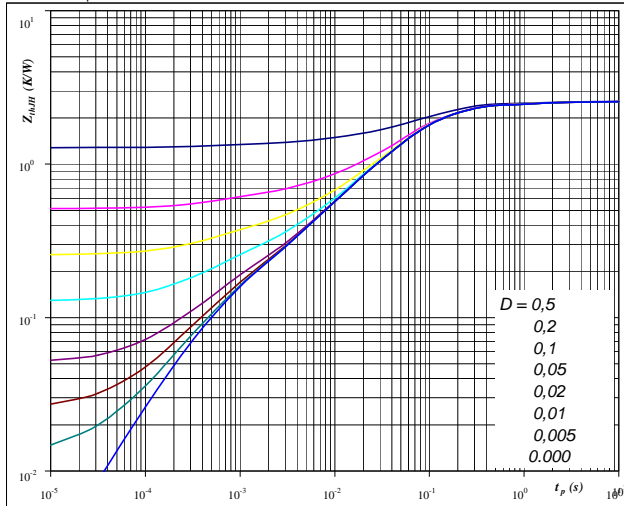


At
 $T_j = 25/125 \text{ } ^\circ\text{C}$
 $V_R = 350 \text{ V}$
 $I_F = 28 \text{ A}$
 $V_{GE} = \pm 15 \text{ V}$

Figure 19 IGBT

IGBT transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At
 $D = t_p / T$
 $R_{thJH} = 2,56 \text{ K/W}$

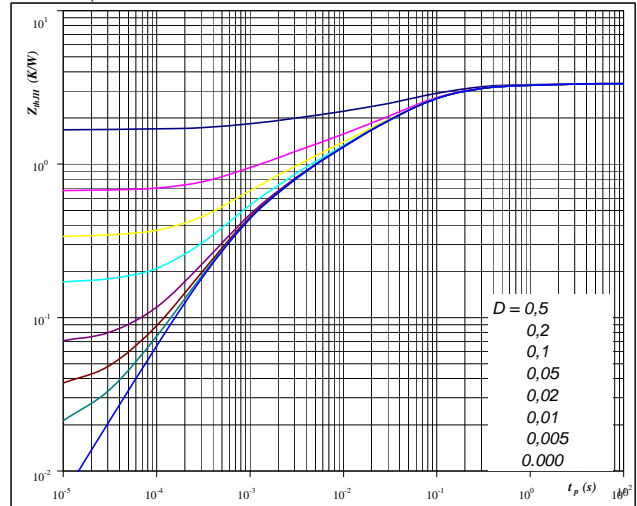
IGBT thermal model values

R (C/W)	Tau (s)
0,10	3,0E+00
0,25	4,8E-01
1,64	7,9E-02
0,32	1,9E-02
0,15	4,2E-03
0,11	5,1E-04

Figure 20 FWD

FWD transient thermal impedance as a function of pulse width

$$Z_{thJH} = f(t_p)$$



At
 $D = t_p / T$
 $R_{thJH} = 3,36 \text{ K/W}$

FWD thermal model values

R (C/W)	Tau (s)
0,11	2,6E+00
0,25	3,8E-01
1,48	7,2E-02
0,67	1,8E-02
0,50	3,4E-03
0,34	7,0E-04

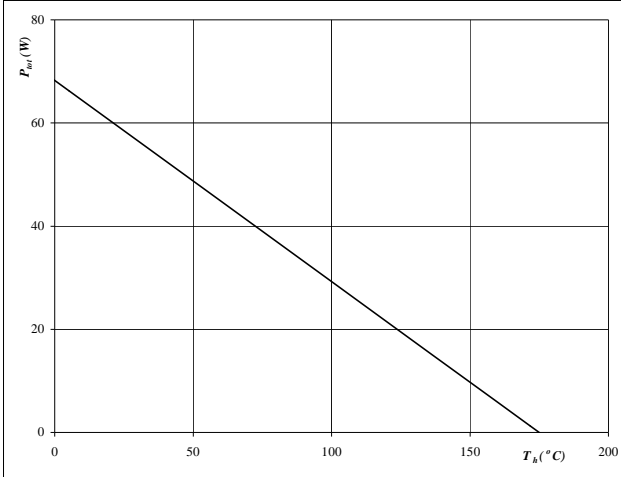
Boost

Neutral Point IGBT and Half Bridge FWD

Figure 21 IGBT

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

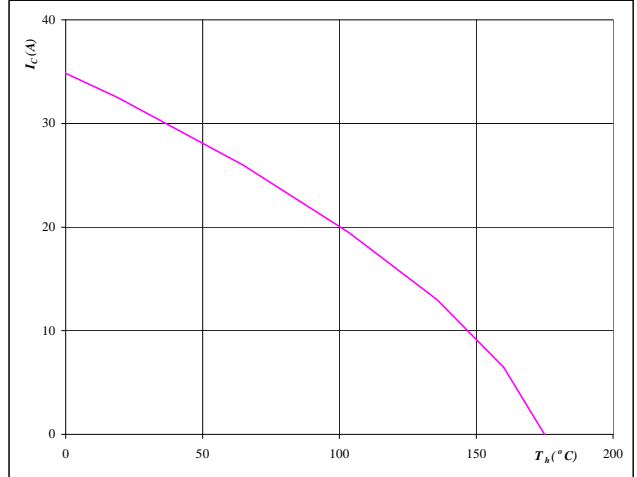


At
 $T_j = 175 \text{ } ^\circ\text{C}$

Figure 22 IGBT

Collector current as a function of heatsink temperature

$$I_C = f(T_h)$$

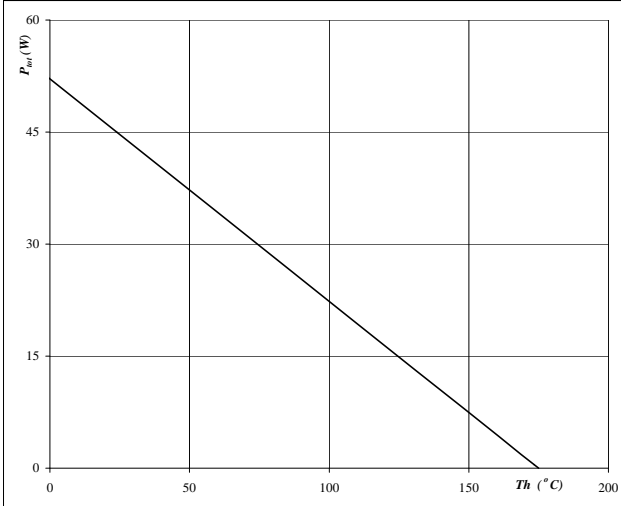


At
 $T_j = 175 \text{ } ^\circ\text{C}$
 $V_{GE} = 15 \text{ V}$

Figure 23 FWD

Power dissipation as a function of heatsink temperature

$$P_{tot} = f(T_h)$$

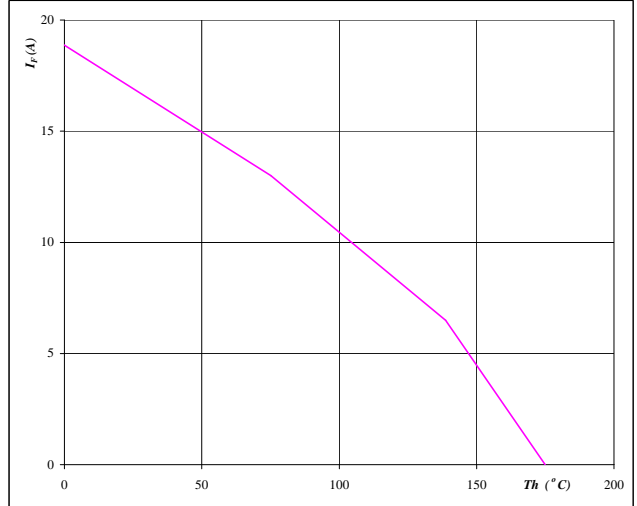


At
 $T_j = 175 \text{ } ^\circ\text{C}$

Figure 24 FWD

Forward current as a function of heatsink temperature

$$I_F = f(T_h)$$



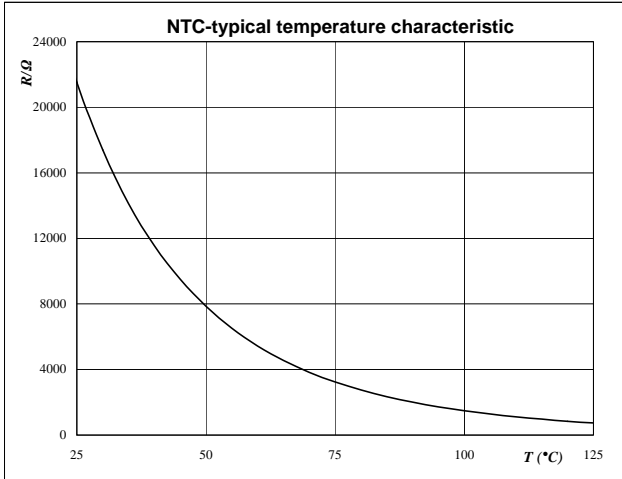
At
 $T_j = 175 \text{ } ^\circ\text{C}$

Thermistor

Figure 1 Thermistor

Typical NTC characteristic
as a function of temperature

$$R_T = f(T)$$

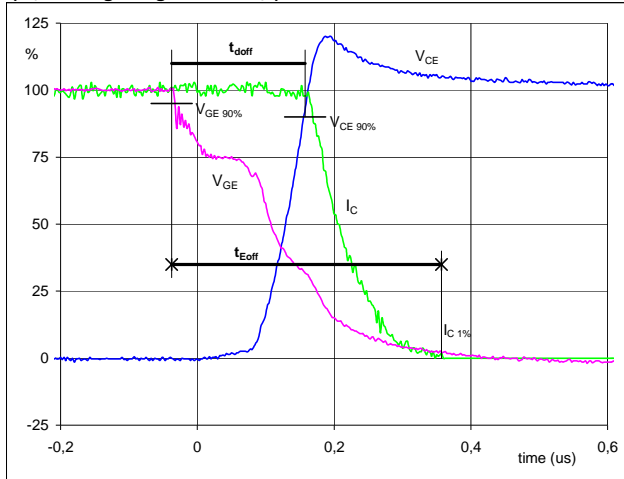


Switching Definitions Neutral Point

General conditions

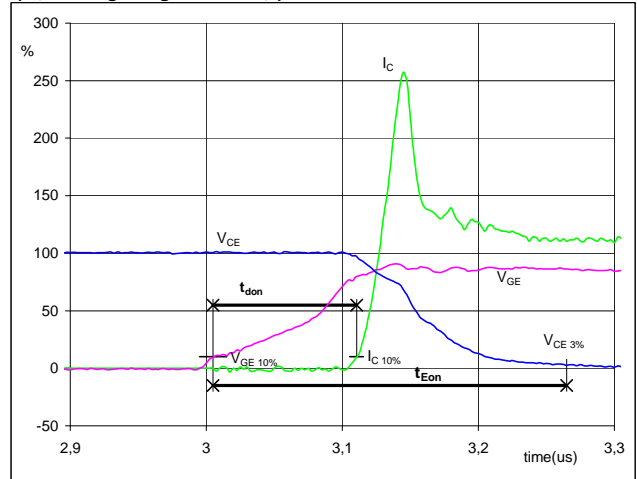
T_j	=	125 °C
R_{gon}	=	16 Ω
R_{goff}	=	16 Ω

Figure 1 Boost IGBT

Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
(t_{Eoff} = integrating time for E_{off})


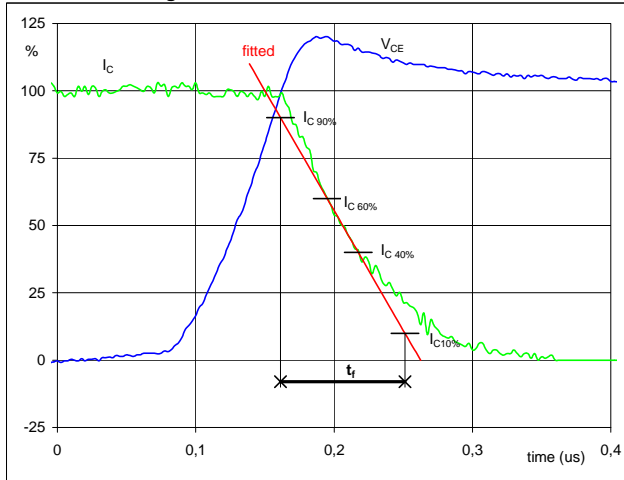
$V_{GE}(0\%) =$	-15	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	350	V
$I_C(100\%) =$	28	A
$t_{doff} =$	0,19	μ s
$t_{Eoff} =$	0,39	μ s

Figure 2 Boost IGBT

Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
(t_{Eon} = integrating time for E_{on})


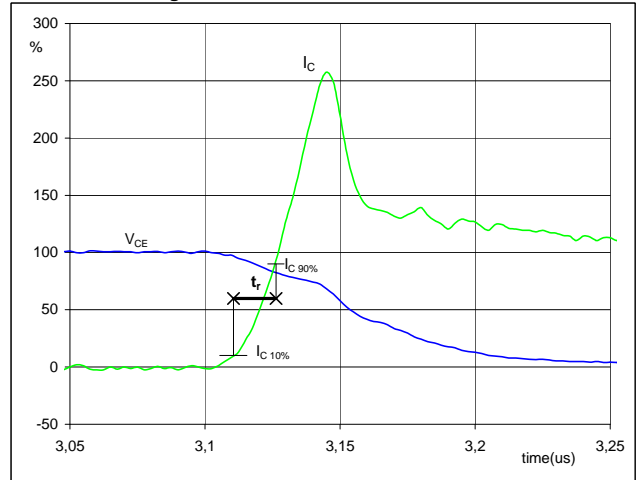
$V_{GE}(0\%) =$	-15	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	350	V
$I_C(100\%) =$	28	A
$t_{don} =$	0,11	μ s
$t_{Eon} =$	0,26	μ s

Figure 3 Boost IGBT

Turn-off Switching Waveforms & definition of t_f


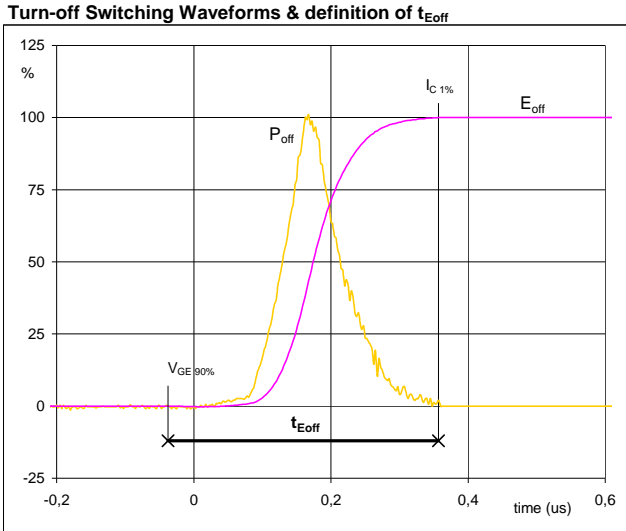
$V_C(100\%) =$	350	V
$I_C(100\%) =$	28	A
$t_f =$	0,09	μ s

Figure 4 Boost IGBT

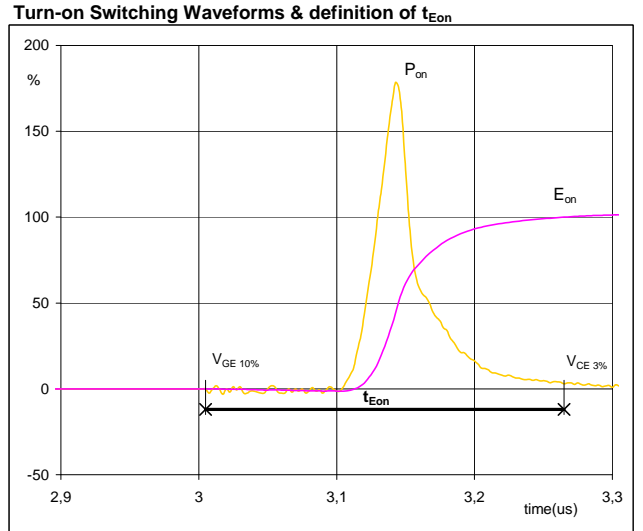
Turn-on Switching Waveforms & definition of t_r


$V_C(100\%) =$	350	V
$I_C(100\%) =$	28	A
$t_r =$	0,02	μ s

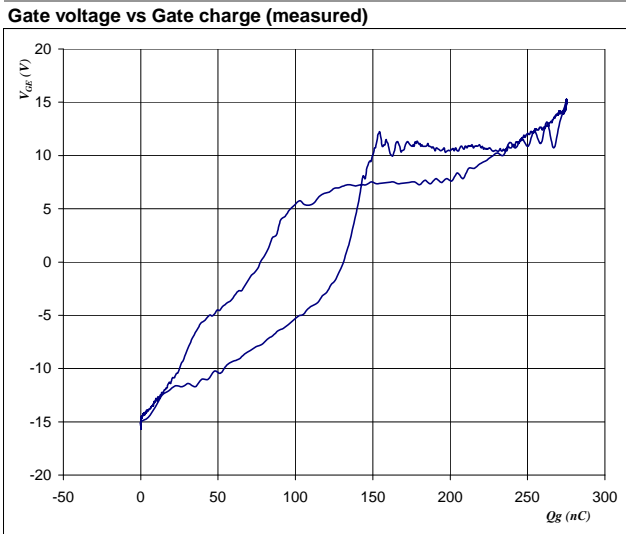
Switching Definitions Neutral Point

Figure 5 Boost IGBT


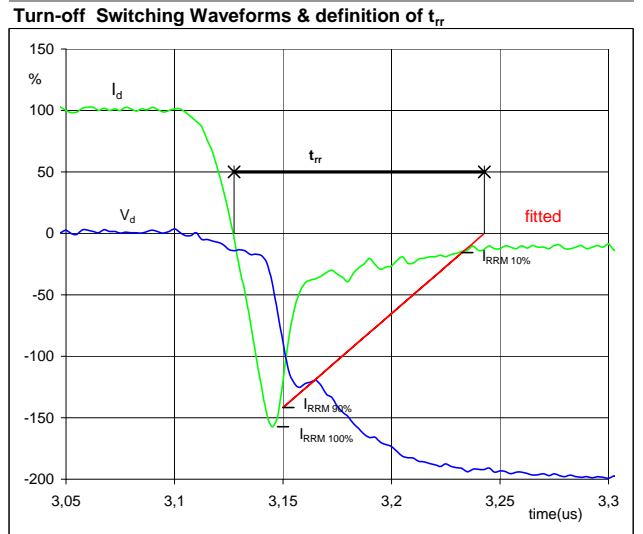
$P_{off} (100\%) = 9,70 \text{ kW}$
 $E_{off} (100\%) = 0,98 \text{ mJ}$
 $t_{Eoff} = 0,39 \text{ }\mu\text{s}$

Figure 6 Boost IGBT


$P_{on} (100\%) = 9,70 \text{ kW}$
 $E_{on} (100\%) = 0,66 \text{ mJ}$
 $t_{Eon} = 0,26 \text{ }\mu\text{s}$

Figure 7 Boost IGBT


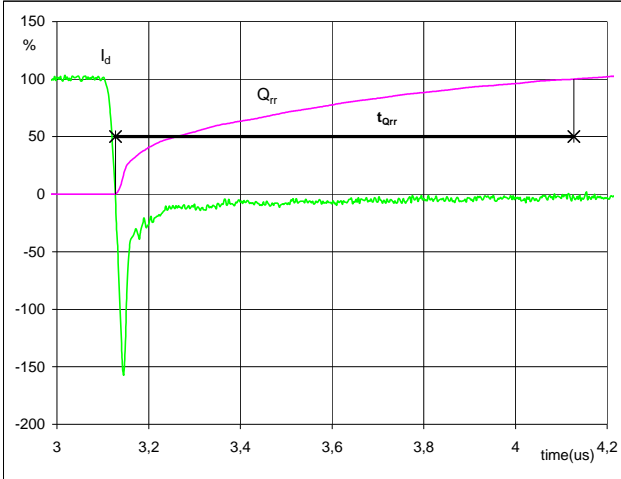
$V_{GEoff} = -15 \text{ V}$
 $V_{GEon} = 15 \text{ V}$
 $V_C (100\%) = 350 \text{ V}$
 $I_C (100\%) = 28 \text{ A}$
 $Q_g = 277 \text{ nC}$

Figure 8 Buck FWD


$V_d (100\%) = 350 \text{ V}$
 $I_d (100\%) = 28 \text{ A}$
 $I_{RRM} (100\%) = -44 \text{ A}$
 $t_{rr} = 0,11 \text{ }\mu\text{s}$

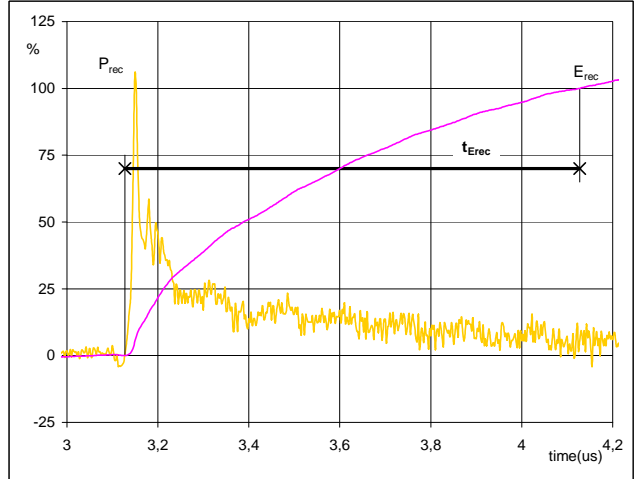
Switching Definitions Neutral Point

Figure 9 Boost IGBT

Turn-on Switching Waveforms & definition of t_{Qrr}
(t_{Qrr} = integrating time for Q_{rr})


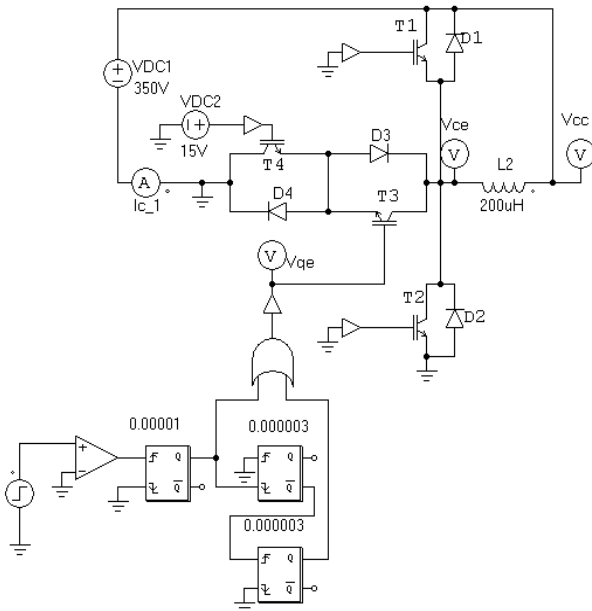
I_d (100%) =	28	A
Q_{rr} (100%) =	2,73	μC
t_{Qrr} =	1,00	μs

Figure 10 Buck FWD

Turn-on Switching Waveforms & definition of t_{Erec}
(t_{Erec} = integrating time for E_{rec})


P_{rec} (100%) =	9,70	kW
E_{rec} (100%) =	0,71	mJ
t_{Erec} =	1,00	μs

Measurement circuits

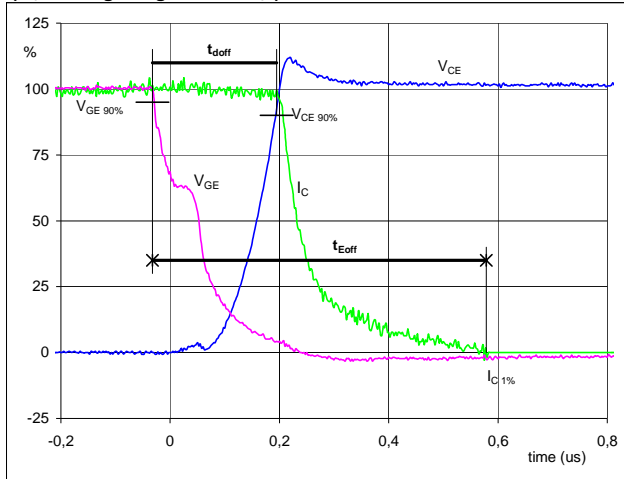
Figure 11
Neutral Point stage switching measurement circuit


Switching Definitions Half Bridge

General conditions

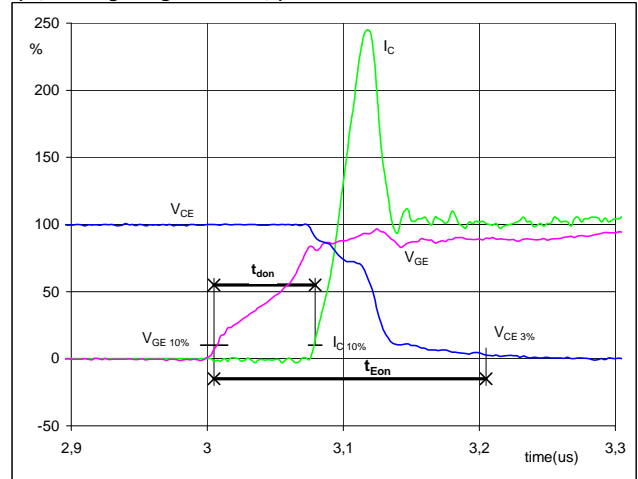
T_j	=	125 °C
R_{gon}	=	8 Ω
R_{goff}	=	8 Ω

Figure 1 Buck IGBT

Turn-off Switching Waveforms & definition of t_{doff} , t_{Eoff}
(t_{Eoff} = integrating time for E_{off})


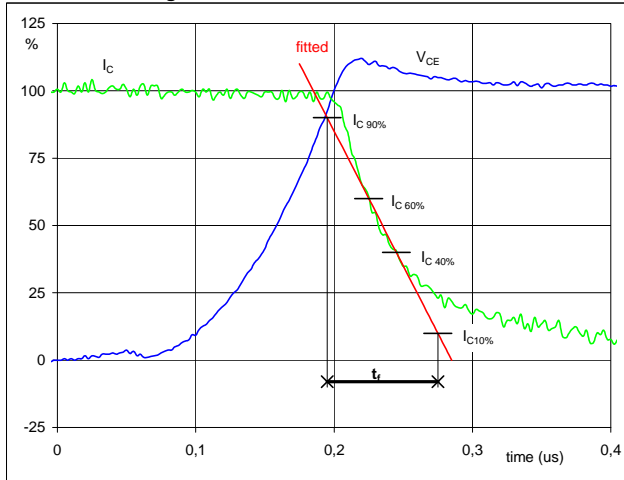
$V_{GE}(0\%) =$	-15	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	350	V
$I_C(100\%) =$	28	A
$t_{doff} =$	0,22	μs
$t_{Eoff} =$	0,61	μs

Figure 2 Buck IGBT

Turn-on Switching Waveforms & definition of t_{don} , t_{Eon}
(t_{Eon} = integrating time for E_{on})


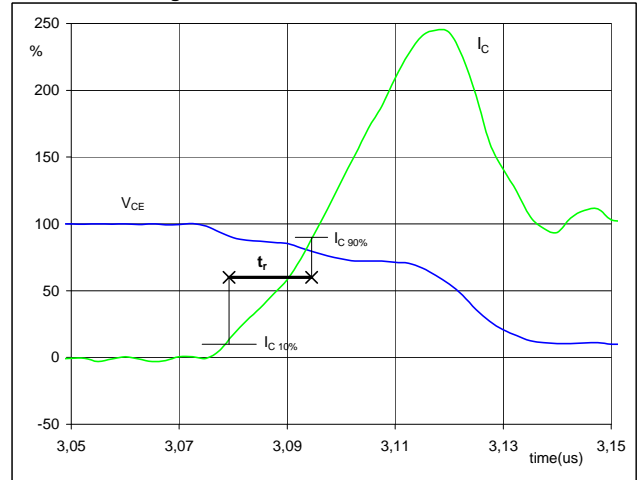
$V_{GE}(0\%) =$	-15	V
$V_{GE}(100\%) =$	15	V
$V_C(100\%) =$	350	V
$I_C(100\%) =$	28	A
$t_{don} =$	0,07	μs
$t_{Eon} =$	0,20	μs

Figure 3 Buck IGBT

Turn-off Switching Waveforms & definition of t_f


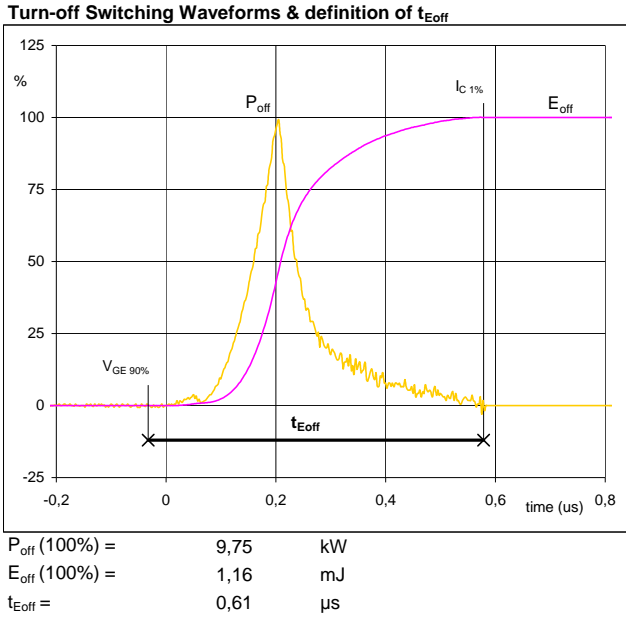
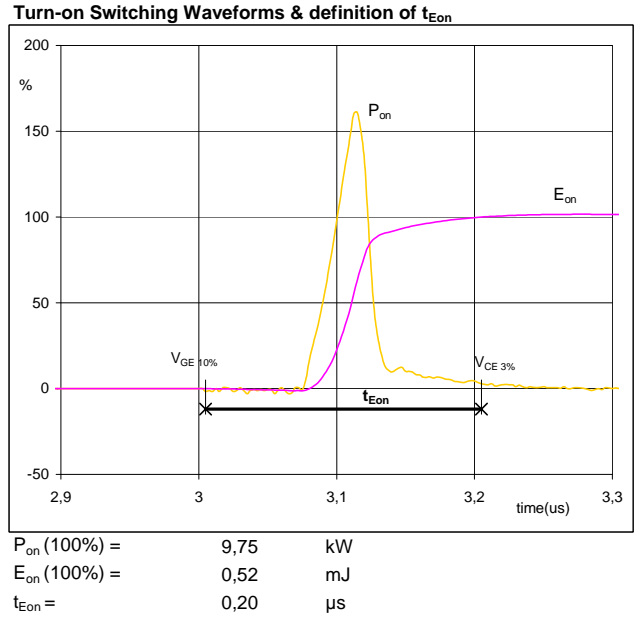
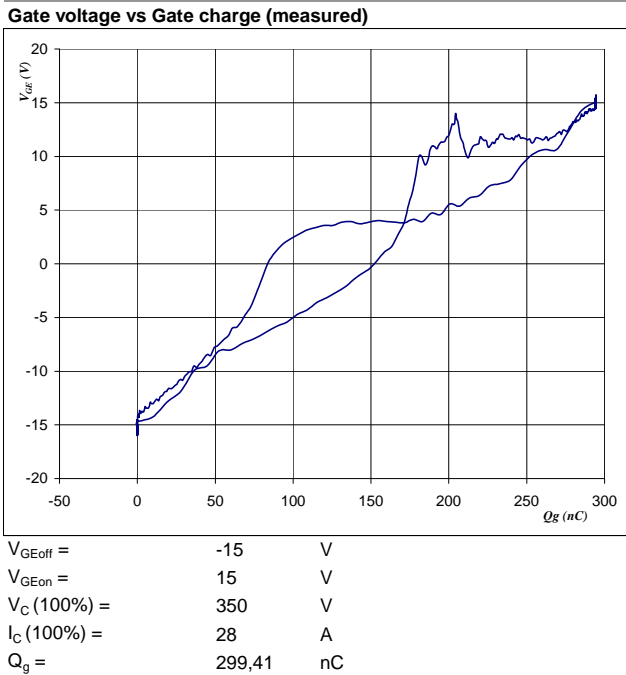
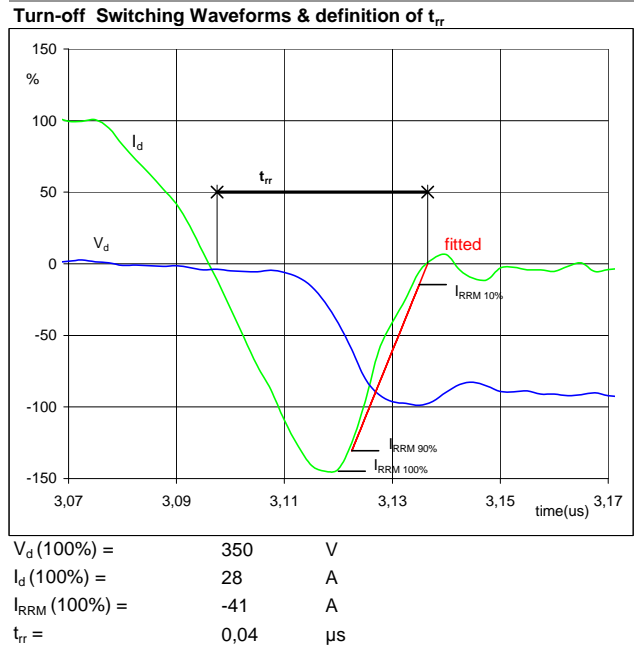
$V_C(100\%) =$	350	V
$I_C(100\%) =$	28	A
$t_f =$	0,08	μs

Figure 4 Buck IGBT

Turn-on Switching Waveforms & definition of t_r


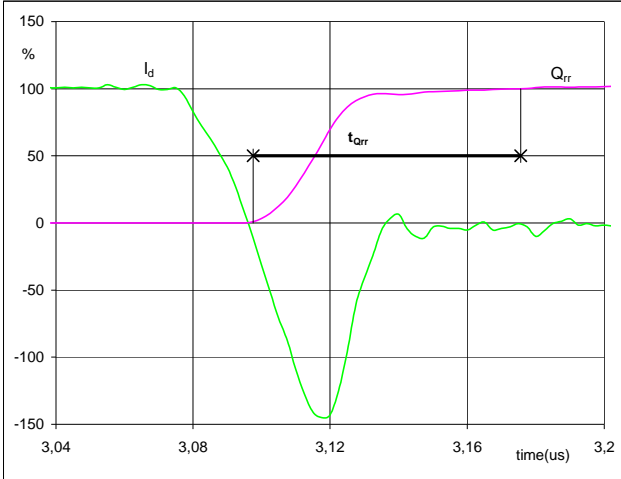
$V_C(100\%) =$	350	V
$I_C(100\%) =$	28	A
$t_r =$	0,02	μs

Switching Definitions Half Bridge

Figure 5 Buck IGBT

Figure 6 Buck IGBT

Figure 7 Buck IGBT

Figure 8 Boost FWD


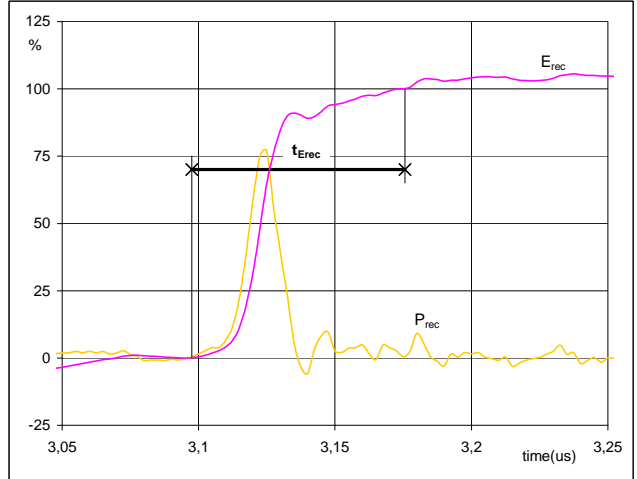
Switching Definitions Half Bridge

Figure 9 Buck IGBT

Turn-on Switching Waveforms & definition of t_{Qrr}
(t_{Qrr} = integrating time for Q_{rr})


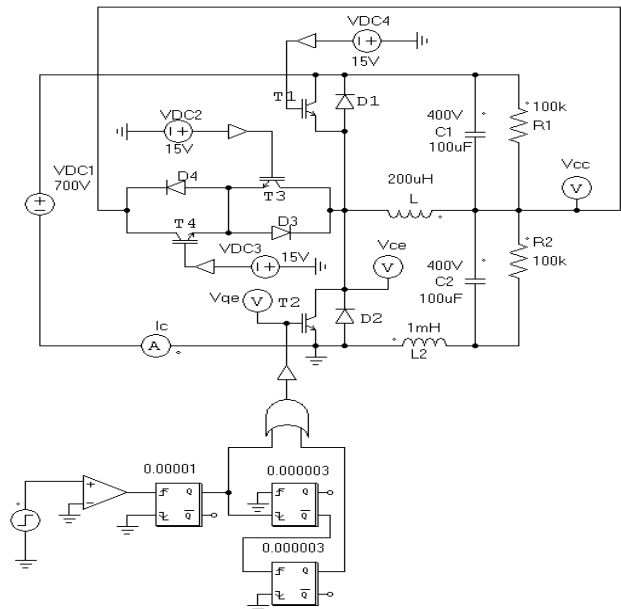
I_d (100%) =	28	A
Q_{rr} (100%) =	0,92	μC
t_{Qrr} =	0,08	μs

Figure 10 Boost FWD

Turn-on Switching Waveforms & definition of t_{Erec}
(t_{Erec} = integrating time for E_{rec})


P_{rec} (100%) =	9,75	kW
E_{rec} (100%) =	0,12	mJ
t_{Erec} =	0,08	μs

Measurement circuits

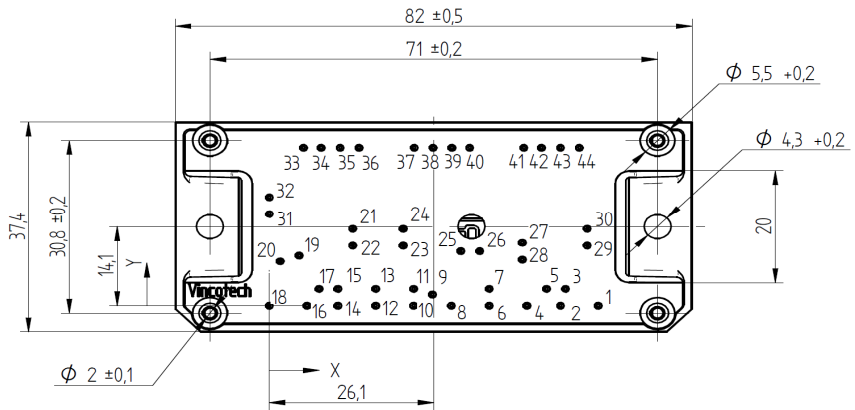
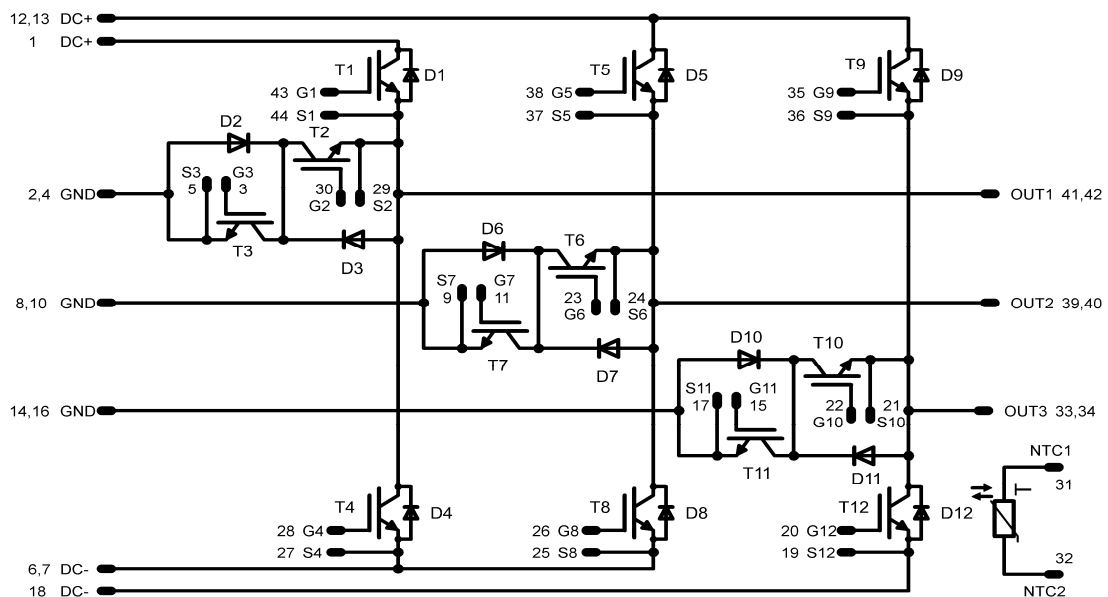
Figure 11
Half Bridge stage switching measurement circuit


Ordering Code and Marking - Outline - Pinout
Ordering Code & Marking

Version	Ordering Code	in DataMatrix as	in packaging barcode as
without thermal paste 12mm housing	10-FY12M3A040SH-M749F08	M749F08	M749F08
without thermal paste 17mm housing	10-F112M3A040SH-M749F09	M749F09	M749F09

Outline

Pin	X	Y	Pin	X	Y
1	52,2	0	23	21,25	10,7
2	46,2	0	24	21,25	13,7
3	47	3	25	30,4	9,7
4	40,9	0	26	33,4	9,7
5	44	3	27	40,15	11,2
6	34,9	0	28	40,15	8,2
7	34,9	3	29	50,45	10,7
8	28,9	0	30	50,45	13,7
9	25,9	2	31	0	16,35
10	22,9	0	32	0	19,35
11	22,9	3	33	5,45	28,2
12	16,9	0	34	8,25	28,2
13	16,9	3	35	11,25	28,2
14	10,9	0	36	14,25	28,2
15	10,9	3	37	23	28,2
16	6	0	38	26	28,2
17	7,9	3	39	29	28,2
18	0	0	40	31,8	28,2
19	4,75	8,9	41	40,4	28,2
20	1,75	7,9	42	43,2	28,2
21	13,25	13,7	43	46,2	28,2
22	13,25	10,7	44	49,2	28,2


Pinout


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